Notice of References Cited Application/Control No. 10/659,257 Examiner Karie O'Neill Applicant(s)/Patent Under Reexamination ABE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2001/0038938	11-2001	Takahashi et al.	429/53
	В	US-		·	
	С	US			
	D	US-		i	
	E	US-		·	
	F	US-			
	G	US-			
	н	US-	5,		
	1	US- ·			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N,	/JP 2000277093 A	10-2000	Japan	KODAMA et al.	
	0					
	Р					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	Ü	
	V	
	w	
	×	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.